

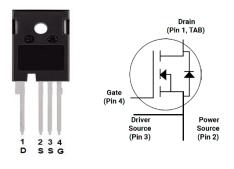
#### Silicon Carbide Power MOSFET

# **Product Summary**

 $V_{DS} = 1200 \text{ V}$   $I_{D}@25^{\circ}\text{C} = 37\text{A}$  $R_{DS(ON)} = 78\text{m}\Omega$ 







TO-247-4

### **Features**

- High Blocking Voltage
- High Frequency Operation
- Low on-resistance
- Fast intrinsic diode with low reverse recovery

# **Applications**

- Motor Drives
- Solar / Wind Inverters
- EV Charging Station

## **Benefits**

- Higher System Efficiency
- Parallel Device Convenience without thermal runaway
- High Temperature Application
- Hard Switching & Higher Reliability
- Easy to drive
- AC/DC converters
- DC/DC converters
- Uninterruptable power supplies

#### Maximum Ratings (T<sub>C</sub>=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Value	Unit
Drain - Source Voltage	$V_{DSmax}$	$V_{GS}$ =0 $V$ , $I_D$ =100 $\mu$ A	1200	V
Gate - Source Voltage (dynamic)	$V_{GSmax}$	AC (f>1 Hz)	-10 / +25	V
Gate - Source Voltage (static)	$V_{GSop}$	static	-5 / +20	V
Continuous Drain Current	$I_{D}$	$V_{GS}$ = 20V, $T_{C}$ =25°C	37	Α
		$V_{GS} = 20V, T_{C} = 100^{\circ}C$	26	
Pulsed Drain Current	I <sub>D(pulse)</sub>	T <sub>C</sub> =25°C	80	Α
Short Circuit Capability	t <sub>sc</sub>	V <sub>DD</sub> =800V, V <sub>GS</sub> =20V	3	μS
Short Circuit Capability	I <sub>DS</sub>	V <sub>DD</sub> =800V, V <sub>GS</sub> =20V	300	Α
Total power dissipation	P <sub>D</sub>	T <sub>C</sub> =25°C	208	W
Operating Junction Temperature	$T_J$		-55 to 175	°C
Storage Temperature	T <sub>STG</sub>		-55 to 175	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.







# **Electrical Characteristics** (T<sub>C</sub>=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit	
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0V, I_D = 100\mu A$	1200	-		V	
		$V_{DS} = V_{GS}$ , $I_D = 5mA$	1.8	3.0	3.7	V	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 5mA,$ $T_{J} = 150^{\circ}C$		2.2			
		$V_{DS} = V_{GS}, I_{D} = 5mA,$ $T_{J} = 175^{\circ}C$		2.1		V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 1200V, V <sub>GS</sub> = 0V	0	5	100	μA	
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = 20V, V_{DS} = 0V$	0	10	200	nA	
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS} = -5V$ , $V_{DS} = 0V$	-200	-10	0	nA	
		$V_{GS} = 20V, I_D = 20 A$		78	98		
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 20V, I_D = 20 A,$ $T_J = 150^{\circ}C$		116		mΩ	
Nesistance	25(611)	$V_{GS} = 20V, I_D = 20 A,$ $T_J = 175^{\circ}C$		129			
		$V_{DS} = 20V, I_{D} = 20 A,$		9.3			
Transconductance	<b>g</b> fs	$V_{DS} = 20V, I_{D} = 20 A,$ $T_{J} = 150^{\circ}C$		9		S	
		$V_{DS} = 20V, I_{D} = 20 A,$ $T_{J} = 175^{\circ}C$		8.9			
Input capacitance	Ciss			1390			
Output capacitance	Coss	$V_{DS} = 1000V, V_{GS} = 0V$		70		pF	
Reverse transfer capacitance	Crss	f = 1MHz		7		1	
C <sub>oss</sub> Stored Energy	Eoss			45		μJ	
Total gate charge	$Q_{g}$	V <sub>DS</sub> = 800V, V <sub>GS</sub> = -5V / 20V		76			
Gate-source charge	$Q_{gs}$	$I_D = 20 \text{ A},$		10		nC	
Gate-drain charge	$Q_{gd}$	ŕ		36			
Internal gate input resistance	$R_{g(int)}$	$f = 1MHz$ , $I_D = 0A$		2.2		Ω	
Turn-On Switching Energy	E <sub>ON</sub>	$V_{DS} = 800 \text{ V}, V_{GS} = -5\text{V}/20\text{V},$		175			
Turn-Off Switching Energy	E <sub>OFF</sub>	$I_D$ = 20A, $R_{G(ext)}$ =4 $\Omega$ , L=200 $\mu$ H		25		μJ	
Turn-On Delay Time	t <sub>d(on)</sub>	\\ - 800\\ \\ - F\\/20\\		11			
Rise Time	t <sub>r</sub>	$V_{DD} = 800V, V_{GS} = -5V/20V$ $I_{D} = 20A, R_{G(ext)} = 4\Omega,$		14		no	
Turn-Off Delay Time	$t_{d(off)}$	L=200µH		22		ns	
Fall Time	t <sub>f</sub>	Ε-200μπ		8			
Avalanche Capability	E <sub>AS</sub>	$V_{DD} = 100V, V_{GS} = 20V, L = 2mH$		225		mJ	
Avalanche Capability	$I_{AV}$	$V_{DD} = 100V, V_{GS} = 20V, L = 2mH$		15		Α	





# $\textbf{Reverse Diode Characteristics} \; (T_{\text{C}}\text{=-}25^{\circ}\text{C unless otherwise specified})$

Parameter	Symbol	Condition	Min	Тур	Max	Unit
		$V_{GS} = -5V, I_{SD} = 10A,$		4.1		
		$V_{GS} = -5V$ , $I_{SD} = 10A$ ,		3.7		
Diode Forward Voltage	$V_{\text{SD}}$	T <sub>J</sub> = 150°C		5.7		V
		$V_{GS} = -5V$ , $I_{SD} = 10A$ ,		3.6		
		T <sub>J</sub> = 175°C		5.0		
Continuous Diode Forward	Is	$V_{GS} = -5V$		35		Α
Current	15	VGS OV				, ·
Reverse Recovery time	$t_{rr}$			30		ns
Reverse Recovery Charge	Q <sub>rr</sub>	$V_{GS} = -5V$ , $I_{SD} = 20A$ ,		250		nC
Peak Reverse Recovery		$V_R$ = 800V, dif/dt = 2600 A/ $\mu$ s		15		Α
Current	Irrm			13		_ ^

#### **Thermal Characteristics**

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Thermal Resistance (per device)	R <sub>th(j-c)</sub>	junction-case		0.55	0.72	°C/W



# **Typical Performance**

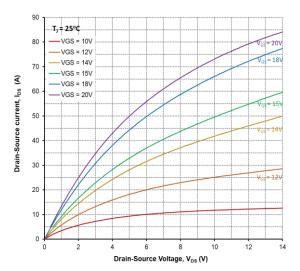


Figure 1. Output Characteristics, T<sub>J</sub> = 25°C

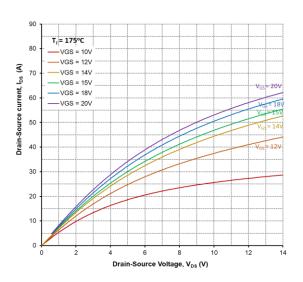


Figure 2. Output Characteristics, T<sub>J</sub> = 175°C

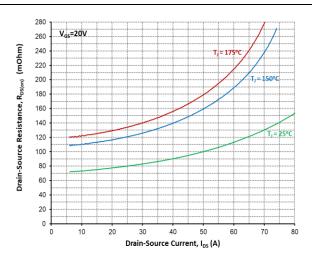


Figure 3. On-Resistance vs. Drain Current For Various Temperatures

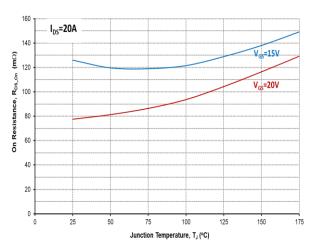


Figure 4. On-Resistance vs. Temperature

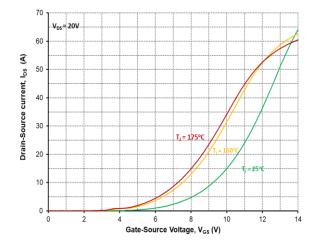


Figure 5. Transfer Characteristic For Various Junction Temperatures

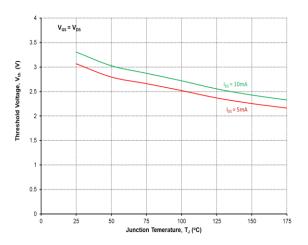


Figure 6. Threshold Voltage vs. Temperature

Revision 1.0 **PRELIMINARY** P.4 of 8



#### **Typical Performance**

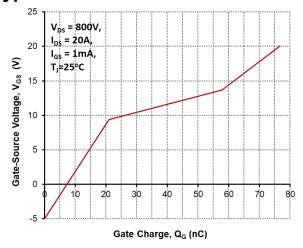


Figure 7. Gate Charge Characteristics

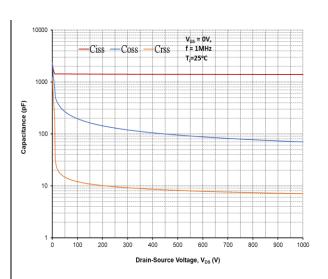


Figure 8. Capacitances vs. Drain-Source Voltage (0-1000V)

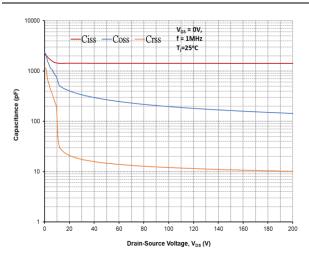


Figure 9. Capacitances vs. Drain-Source Voltage (0-200V)

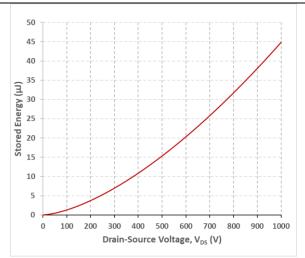


Figure 10. Output Capacitor Stored Energy

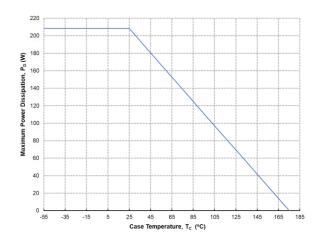


Figure 11. Maximum Power Dissipation Derating vs.

Case Temperature

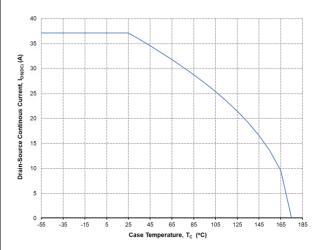


Figure 12. Continuous Drain Current Derating vs. Case Temperature





## **Typical Performance**

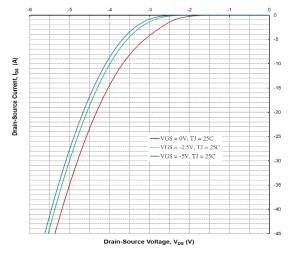


Figure 13. Body Diode Characteristics @ 25°C

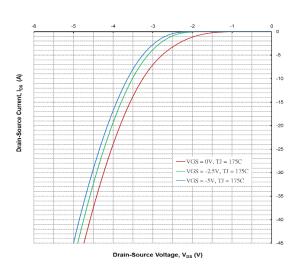


Figure 14. Body Diode Characteristics @ 175°C

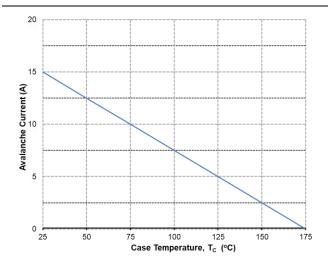


Figure 15. Single Avalanche vs. Temperature

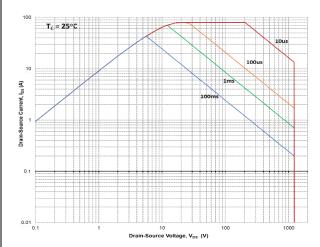
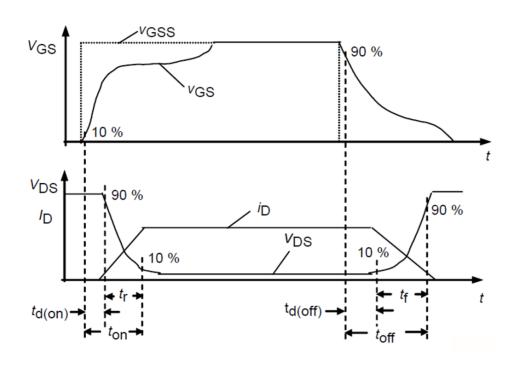
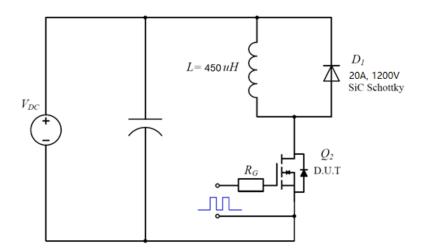


Figure 16. Safe Operating Area



# **Switching Times Definition and Test Circuit**

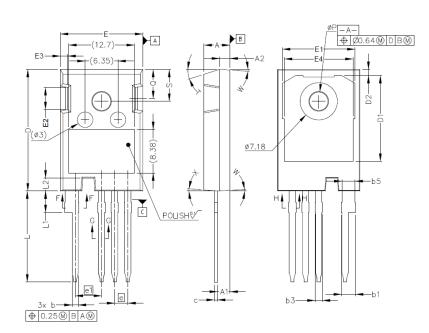


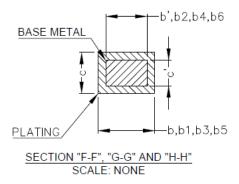




### **Package Dimensions**

(TO-247-4 Package)





CVMPOL	MILLIMETERS			
SYMBOL	MIN	MAX		
Α	4.83	5.21		
A1	2.29	2.54		
A2	1.91	2.16		
b'	1.07	1.28		
b	1.07	1.33		
b1	2.39	2.94		
b2	2.39	2.84		
b3	1.07	1.60		
b4	1.07	1.50		
b5	2.39	2.69		
b6	2.39	2.64		
c'	0.55	0.65		
С	0.55	0.68		
D	23.30	23.60		
D1	16.25	17.65		
D2	0.95	1.25		
Е	15.75	16.13		
E1	13.10	14.15		
E2	3.68	5.10		
E3	1.00	1.90		
E4	12.38	13.43		
е	2.54 BSC			
e1	5.08	BSC		
N	4			
L	17.31	17.82		
L1	3.97	4.37		
L2	2.35	2.65		
øΡ	3.51	3.65		
	5.49 6.00			
Q S	6.04	6.30		
T	17.5° F	REF.		
W	3.5 ° REF.			
X	4° REF.			

NOTE ; 1. ALL METAL SURFACES: TIN PLATED, EXCEPT AREA OF CUT

<sup>2.</sup> DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.

<sup>3.</sup> ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES.